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Try our New Full-text Search Prototype **GO**

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- 1) Enter a single keyword, phrase, or Boolean expression.
Example: acoustic imaging (means the phrase acoustic imaging plus any stem variations)
- 2) Limit your search by using search operators and field codes, if desired.
Example: optical <and> (fiber <or> fibre) <in> ti
- 3) Limit the results by selecting Search Options.
- 4) Click Search. See [Search Examples](#)

```
recog* <and> (dct <or>
((cosine <or> orthogonal)
<near/2> transform*)) <and>
image
```

Start Search **Clear**

Note: This function returns plural and suffixed forms of the keyword(s).

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Field codes: au (author), ti (title), ab (abstract), jn (publication name), de (index term) [More](#)

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